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SHEET 1 OF 1

Form PTO 146 (Modified) U.S. DEPARTMENT OF COMMERCE PATENT & TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT		ATTY DOCKET NO 210374US0	SERIAL NO. 09/903,785	
		APPLICANT Laurence SEBILLOTTE-ARNAUD, et al.		
		FILING DATE July 13, 2001	GROUP 1751	

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
~	AA 4,450,090	05/22/84	Kinney, J.			
~	AB 5,824,296	10/20/98	Dubief, et al.			
~	AC 6,277,797	08/21/01	Glenn, Jr., et al.			
~	AD US 2002/0039976	04/04/02	Sebillotte-Arnaud, et al.			
AE						
AF						
AG						
AH						
AI						
AJ						
AK						
AL						
AM						
AN						

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO
~	AO WO 93/08793	05/13/93	WIPO	X	
~	AP EP 0 692 248 A1	01/17/96	EPO (English Abstract Provided)		X
~	AQ EP 0 514 760 A1	11/25/92	EPO	X	
~	AR WO 97/49381	12/31/97	WIPO	X	
~	AS WO 00/38621	07/06/00	WIPO	X	
~	AT WO 96/28140	09/19/96	WIPO	X	
~	AU WO 99/38488	08/05/99	WIPO	X	
~	AV EP 1 172 095	01/16/02	EPO (English Abstract Provided)		X

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

~	AW	Chemical Abstracts, AN 1987:38232, JP 61 180712, August 13, 1986. XP-002168472
~	AX	Chemical Abstracts, AN 1992-180847, JP 04 120015, April 21, 1992. XP-002168473
	AY	
	AZ	<input type="checkbox"/> Additional References sheet(s) attached

Examiner *M* Date Considered *10/30/03*

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.